### 3.3 V/5 V ECL $\div 2$ Divider

## MC10EP32, MC100EP32

## Description

The MC10/100EP32 is an integrated $\div 2$ divider with differential CLK inputs.

The $\mathrm{V}_{\mathrm{BB}}$ pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to $\mathrm{V}_{\mathrm{BB}}$ as a switching reference voltage. $\mathrm{V}_{\mathrm{BB}}$ may also rebias AC coupled inputs. When used, decouple $\mathrm{V}_{\mathrm{BB}}$ and $\mathrm{V}_{\mathrm{CC}}$ via a $0.01 \mu \mathrm{~F}$ capacitor and limit current sourcing or sinking to 0.5 mA . When not used, $\mathrm{V}_{\mathrm{BB}}$ should be left open.

The reset pin is asynchronous and is asserted on the rising edge. Upon power-up, the internal flip-flops will attain a random state; the reset allows for the synchronization of multiple EP32's in a system.

The 100 Series contains temperature compensation.

## Features

- 350 ps Typical Propagation Delay
- Maximum Frequency > 4 GHz Typical (Figure 3)
- PECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$ to 5.5 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ with $\mathrm{V}_{\mathrm{EE}}=-3.0 \mathrm{~V}$ to -5.5 V
- Open Input Default State
- Safety Clamp on Inputs
- Q Output Will Default LOW with Inputs Open or at $\mathrm{V}_{\mathrm{EE}}$
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free and are RoHS Compliant


MARKING DIAGRAMS*


| H | $=$ MC10 | A | $=$ Assembly Location |
| :--- | :--- | :--- | :--- |
| K | $=$ MC100 | L | $=$ Wafer Lot |
| $3 K$ | $=$ MC100 | Y | $=$ Year |
| M | $=$ Date Code | W | $=$ Work Week |
|  |  | - | $=$ Pb-Free Package |

(Note: Microdot may be in either location)
*For additional marking information, refer to Application Note AND8002/D.

## ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

## MC10EP32, MC100EP32



Figure 1. 8-Lead Pinout (Top View) and Logic Diagram

Table 1. PIN DESCRIPTION

| Pin | Function |
| :--- | :--- |
| CLK, CLK* | ECL Clock Inputs |
| Reset* $^{*}$ | ECL Asynchronous Reset |
| $V_{B B}$ | Reference Voltage Output |
| Q, $\bar{Q}$ | ECL Data Outputs |
| $V_{\text {CC }}$ | Positive Supply |
| $V_{\text {EE }}$ | Negative Supply |
| EP | (DFN-8 only) Thermal exposed pad <br> must be connected to a sufficient thermal <br> conduit. Electrically connect to the most <br> negative supply (GND) or leave uncon- <br> nected, floating open. |

*Pins will default LOW when left open.

Table 2. TRUTH TABLE

| CLK | CLK | RESET | Q | Q |
| :---: | :---: | :---: | :---: | :---: |
| $X$ | $X$ | Z | L | H |
| $Z$ | $Z$ | L | F | F |

Z = LOW to HIGH Transition
Z $=$ HIGH to LOW Transition
F = Divide by 2 Function


Figure 2. Timing Diagram

Table 3. ATTRIBUTES

| Characteristics | Value |
| :--- | :---: |
| Internal Input Pulldown Resistor | $75 \mathrm{k} \Omega$ |
| Internal Input Pullup Resistor | $\mathrm{N} / \mathrm{A}$ |
| ESD Protection <br> Human Body Model <br> Machine Model <br> Charged Device Model |  |
| Moisture Sensitivity, Indefinite Time Out of Drypack (Note 1) | $>4 \mathrm{kV}$ |
| SOIC-8 NB <br> TSSOP-8 <br> DFN-8 | $>200 \mathrm{~V}$ |
| Flammability Rating |  |
| Oxygen Index: 28 to 34 | Pb-Free Pkg |
| Transistor Count | Level 1 |
| Level 3 |  |
| Leevel 1 |  |

1. For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 6 | V |
| $\mathrm{V}_{\mathrm{EE}}$ | NECL Mode Power Supply | $\mathrm{V}_{\text {CC }}=0 \mathrm{~V}$ |  | -6 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{1} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{\mathrm{I}} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous Surge |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | mA |
| $\mathrm{I}_{\mathrm{BB}}$ | $\mathrm{V}_{\text {BB }}$ Sink/Source |  |  | $\pm 0.5$ | mA |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Temperature Range |  |  | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\mathrm{JA}}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{aligned} & 0 \text { Ifpm } \\ & 500 \text { Ifpm } \end{aligned}$ | SOIC-8 NB | $\begin{aligned} & \hline 190 \\ & 130 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | SOIC-8 NB | 41 to 44 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\mathrm{JA}}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{aligned} & 0 \text { lfpm } \\ & 500 \text { lfpm } \end{aligned}$ | TSSOP-8 | $\begin{aligned} & 185 \\ & 140 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | TSSOP-8 | 41 to 44 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{array}{\|l\|} \hline 0 \text { lfpm } \\ 500 \text { lfpm } \end{array}$ | DFN8 | $\begin{gathered} 129 \\ 84 \end{gathered}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | (Note 1) | DFN8 | 35 to 40 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) | <2 to 3 sec @ $260^{\circ} \mathrm{C}$ |  | 265 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. JEDEC standard multilayer board - 2S2P (2 signal, 2 power)

Table 5. 10EP DC CHARACTERISTICS, PECL ( $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current | 23 | 30 | 40 | 23 | 30 | 40 | 23 | 30 | 40 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 2165 | 2290 | 2415 | 2230 | 2355 | 2480 | 2290 | 2415 | 2540 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 1365 | 1490 | 1615 | 1430 | 1555 | 1680 | 1490 | 1615 | 1740 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 2090 |  | 2415 | 2155 |  | 2480 | 2215 |  | 2540 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | 1365 |  | 1690 | 1430 |  | 1755 | 1490 |  | 1815 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 1790 | 1890 | 1990 | 1855 | 1955 | 2055 | 1915 | 2015 | 2115 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.0 |  | 3.3 | 2.0 |  | 3.3 | 2.0 |  | 3.3 | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}} . \mathrm{V}_{\mathrm{EE}}$ can vary +0.3 V to -2.2 V .
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\text {IHCMR }}$. max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal.

## MC10EP32, MC100EP32

Table 6. 10EP DC CHARACTERISTICS, PECL ( $\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}($ Note 1) $)$

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $I_{\text {EE }}$ | Power Supply Current | 23 | 30 | 40 | 23 | 30 | 40 | 23 | 30 | 40 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3865 | 3990 | 4115 | 3930 | 4055 | 4180 | 3990 | 4115 | 4240 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 2) | 3065 | 3190 | 3315 | 3130 | 3255 | 3380 | 3190 | 3315 | 3440 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3790 |  | 4115 | 3855 |  | 4180 | 3915 |  | 4240 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | 3065 |  | 3390 | 3130 |  | 3455 | 3190 |  | 3515 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 3490 | 3590 | 3690 | 3555 | 3655 | 3755 | 3615 | 3715 | 3815 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.0 |  | 5.0 | 2.0 |  | 5.0 | 2.0 |  | 5.0 | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}} . \mathrm{V}_{\mathrm{EE}}$ can vary +2.0 V to -0.5 V .
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\mathrm{IHCMR}}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\mathrm{IHCMR}}$ range is referenced to the most positive side of the differential input signal.

Table 7. 10EP DC CHARACTERISTICS, NECL ( $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=-5.5 \mathrm{~V}$ to -3.0 V (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| IEE | Power Supply Current | 23 | 30 | 40 | 23 | 30 | 40 | 23 | 30 | 40 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1135 | -1010 | -885 | -1070 | -945 | -820 | -1010 | -885 | -760 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1935 | -1810 | -1685 | -1870 | -1745 | -1620 | -1810 | -1685 | -1560 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | -1210 |  | -885 | -1145 |  | -820 | -1085 |  | -760 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | -1935 |  | -1610 | -1870 |  | -1545 | -1810 |  | -1485 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | -1510 | -1410 | -1310 | -1445 | -1345 | -1245 | -1385 | -1285 | -1185 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | $\mathrm{V}_{\mathrm{EE}}+2.0$ |  | 0.0 | $\mathrm{V}_{\mathrm{EE}}+2.0$ |  | 0.0 | $\mathrm{V}_{\mathrm{EE}}+2.0$ |  | 0.0 | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal.

## MC10EP32, MC100EP32

Table 8. 100EP DC CHARACTERISTICS, PECL $\left(\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\text {EE }}=0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current | 23 | 30 | 37 | 26 | 34 | 40 | 28 | 36 | 42 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 2155 | 2280 | 2405 | 2155 | 2280 | 2405 | 2155 | 2280 | 2405 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 1355 | 1480 | 1605 | 1355 | 1480 | 1605 | 1355 | 1480 | 1605 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 2075 |  | 2420 | 2075 |  | 2420 | 2075 |  | 2420 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | 1355 |  | 1675 | 1355 |  | 1675 | 1355 |  | 1675 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 1775 | 1875 | 1975 | 1775 | 1875 | 1975 | 1775 | 1875 | 1975 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.0 |  | 3.3 | 2.0 |  | 3.3 | 2.0 |  | 3.3 | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary +0.3 V to -2.2 V .
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\mathrm{IHCMR}}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\mathrm{IHCMR}}$ range is referenced to the most positive side of the differential input signal.

Table 9. 100EP DC CHARACTERISTICS, PECL ( $\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| IEE | Power Supply Current | 23 | 30 | 37 | 26 | 34 | 40 | 28 | 36 | 42 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3855 | 3980 | 4105 | 3855 | 3980 | 4105 | 3855 | 3980 | 4105 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3055 | 3180 | 3305 | 3055 | 3180 | 3305 | 3055 | 3180 | 3305 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3775 |  | 4120 | 3775 |  | 4120 | 3775 |  | 4120 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | 3055 |  | 3375 | 3055 |  | 3375 | 3055 |  | 3375 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 3475 | 3575 | 3675 | 3475 | 3575 | 3675 | 3475 | 3575 | 3675 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.0 |  | 5.0 | 2.0 |  | 5.0 | 2.0 |  | 5.0 | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm .

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}} . \mathrm{V}_{\mathrm{EE}}$ can vary +2.0 V to -0.5 V .
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{cc}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\mathrm{EE}}, \mathrm{V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal.

Table 10. 100EP DC CHARACTERISTICS, NECL (VCC $=0 \mathrm{~V} ; \mathrm{V}_{\text {EE }}=-5.5 \mathrm{~V}$ to -3.0 V (Note 1))

|  | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Symbol |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $l_{\text {EE }}$ | Power Supply Current | 23 | 30 | 37 | 26 | 34 | 40 | 28 | 36 | 42 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1145 | -1020 | -895 | -1145 | -1020 | -895 | -1145 | -1020 | -895 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1945 | -1820 | -1695 | -1945 | -1820 | -1695 | -1945 | -1820 | -1695 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | -1225 |  | -880 | -1225 |  | -880 | -1225 |  | -880 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | -1945 |  | -1625 | -1945 |  | -1625 | -1945 |  | -1625 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | -1525 | -1425 | -1325 | -1525 | -1425 | -1325 | -1525 | -1425 | -1325 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | $\mathrm{V}_{\mathrm{EE}}+2.0$ |  | 0.0 | $\mathrm{V}_{\mathrm{EE}+2.0}$ |  | 0.0 | $\mathrm{V}_{\mathrm{EE}+2.0}$ |  | 0.0 | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.
2. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal.

Table 11. AC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-3.0 \mathrm{~V}\right.$ to -5.5 V or $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$ to $5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | -40 ${ }^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{V}_{\text {OPP }}$ | Output Voltage Amplitude (See Figure 3) $\begin{aligned} & f_{\text {in }}<3.5 \mathrm{GHz} \\ & \mathrm{f}_{\text {in }} @ 4.0 \mathrm{GHz} \end{aligned}$ | 640 | $\begin{aligned} & 700 \\ & 740 \end{aligned}$ |  | 630 | $\begin{aligned} & 700 \\ & 710 \end{aligned}$ |  | 500 | $\begin{aligned} & 700 \\ & 600 \end{aligned}$ |  | mV |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH},}, \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation Delay to Output Differential CLK to Q, $\bar{Q}$ 10 Series RESET to $\mathrm{Q}, \overline{\mathrm{Q}}$ 100 Series RESET to Q, $\bar{Q}$ | $\begin{aligned} & 250 \\ & 220 \\ & 320 \end{aligned}$ | $\begin{aligned} & 330 \\ & 290 \\ & 400 \end{aligned}$ | $\begin{aligned} & 420 \\ & 390 \\ & 480 \end{aligned}$ | $\begin{aligned} & 270 \\ & 250 \\ & 320 \end{aligned}$ | $\begin{aligned} & 350 \\ & 300 \\ & 400 \end{aligned}$ | $\begin{aligned} & 450 \\ & 390 \\ & 480 \end{aligned}$ | $\begin{aligned} & 320 \\ & 320 \\ & 375 \end{aligned}$ | $\begin{aligned} & 400 \\ & 380 \\ & 450 \end{aligned}$ | $\begin{aligned} & 480 \\ & 460 \\ & 525 \end{aligned}$ | ps |
| $\mathrm{t}_{\mathrm{RR}}$ | Set/Reset Recovery | 200 | 175 |  | 200 | 175 |  | 200 | 175 |  | ps |
| tpw | Minimum Pulse width RESET | 550 | 475 |  | 550 | 475 |  | 550 | 475 |  | ps |
| $\mathrm{t}_{\text {JITTER }}$ | CLOCK Random Jitter (RMS) $\mathrm{f}_{\text {in }}<3.5 \mathrm{GHz}$ $\mathrm{f}_{\text {in }} @ \leq 4.0 \mathrm{GHz}$ |  | $\begin{aligned} & 0.5 \\ & 0.5 \end{aligned}$ | 1.5 |  | $\begin{aligned} & 0.5 \\ & 0.5 \end{aligned}$ | 1.5 |  | $\begin{aligned} & 0.5 \\ & 0.5 \end{aligned}$ | 1.5 | ps |
| $\mathrm{V}_{\mathrm{PP}}$ | Input Voltage Swing (Differential Configuration) | 150 | 800 | 1200 | 150 | 800 | 1200 | 150 | 800 | 1200 | mV |
| $\mathrm{t}_{\mathrm{r}}$ $\mathrm{t}_{\mathrm{f}}$ | Output Rise/Fall Times Q, $\bar{Q}$ | 50 | 100 | 150 | 70 | 120 | 170 | 70 | 130 | 200 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

1. Measured using a 750 mV source, $50 \%$ duty cycle clock source. All loading with $50 \Omega$ to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

## MC10EP32, MC100EP32



Figure 3. Input Frequency ( $\mathrm{f}_{\text {in }}$ ) Versus Typical Output Voltage ( $\mathrm{V}_{\mathrm{OPP}}$ )


Figure 4. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices.)

ORDERING INFORMATION

| Device | Package <br> Shipping |  |
| :--- | :---: | :---: |
| MC10EP32DG | SOIC-8 NB <br> (Pb-Free) | 98 Units / Tube |
| MC10EP32DR2G | SOIC-8 NB <br> (Pb-Free) | 2500 / Tape \& Reel |
| MC10EP32DTG | TSSOP-8 <br> (Pb-Free) | 100 Units / Tube |
| MC10EP32DTR2G | TSSOP-8 <br> (Pb-Free) | $2500 /$ Tape \& Reel |
| MC100EP32DG | SOIC-8 NB <br> (Pb-Free) | 98 Units / Tube |
| MC100EP32DR2G | SOIC-8 NB <br> (Pb-Free) | 2500 / Tape \& Reel |
| MC100EP32DTG | TSSOP-8 <br> (Pb-Free) | 100 Units / Tube |
| MC100EP32DTR2G | TSSOP-8 <br> (Pb-Free) | 2500 / Tape \& Reel |
| MC100EP32MNR4G | DFN-8 <br> (Pb-Free) | 1000 / Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V )
AN1503/D - ECLinPS ${ }^{m}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family
AN1568/D - Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

DFN8 2x2, 0.5P
CASE 506AA-01
ISSUE E
DATE 22 JAN 2010

## SCALE 4:1



NOTES:
. Dimensioning and tolerancing per ASME Y14.5M, 1994
CONTROLLING DIMENSION: MILLIMETERS.
2. CIMENSION B APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

|  | MILLIMETERS |  |
| :---: | :---: | :---: |
| DIM | MIN | MAX |
| A | 0.80 | 1.00 |
| A1 | 0.00 | 0.05 |
| A3 | 0.20 REF |  |
| b | 0.20 | 10.30 |
| D | 2.00 BSC |  |
| D2 | 1.10 | 1.30 |
| E | 2.00 BS |  |
| E2 | 0.70 | 0.90 |
| e | 0.50 BSC |  |
| K | 0.30 REF |  |
| L | 0.25 | 0.35 |
| L1 | ---1 | 0.10 |

> GENERIC
> MARKING DIAGRAM*
> XX = Specific Device Code
> M = Date Code
> - = Pb-Free Device
*This information is generic. Please refer to device data sheet for actual part marking. $\mathrm{Pb}-\mathrm{Free}$ indicator, " G " or microdot " $\mathrm{\nabla}$ ", may or may not be present.

RECOMMENDED SOLDERING FOOTPRINT*

*For additional information on our Pb -Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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| ---: | :--- | :--- | :--- |
| DESCRIPTION: | DFN8, 2.0X2.0, 0.5MM PITCH | PAGE 1 OF 1 |

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SOIC-8 NB
CASE 751-07
ISSUE AK
SCALE 1:1
DATE 16 FEB 2011


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. 751-01 THRU 751-06 ARE OBSOLETE. NEW
7. 751-01 THRU 751-06 AR
STANDARD IS 751-07.

| DIM | MILLIMETERS |  | INCHES |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |  |  |
|  | 4.80 | 5.00 | 0.189 | 0.197 |  |  |
| B | 3.80 | 4.00 | 0.150 | 0.157 |  |  |
| C | 1.35 | 1.75 | 0.053 | 0.069 |  |  |
| D | 0.33 | 0.51 | 0.013 | 0.020 |  |  |
| G | 1.27 |  | BSC | 0.050 |  | BSC |
| H | 0.10 | 0.25 | 0.004 | 0.010 |  |  |
| J | 0.19 | 0.25 | 0.007 | 0.010 |  |  |
| K | 0.40 | 1.27 | 0.016 | 0.050 |  |  |
| M | 0 | $\circ$ | $8{ }^{\circ}$ | $0{ }^{\circ}$ |  |  |
| N | 0.25 | 0.50 | 0.010 | 0.020 |  |  |
| $\mathbf{S}$ | 5.80 | 6.20 | 0.228 | 0.244 |  |  |

## GENERIC

MARKING DIAGRAM*



XXXXX = Specific Device Code
A = Assembly Location
L = Wafer Lot
= Year
$\begin{array}{ll}\mathrm{W} & =\text { Work Week } \\ \text { - } & =\text { Pb-Free Package }\end{array}$
*This information is generic. Please refer to device data sheet for actual part marking. $\mathrm{Pb}-\mathrm{Free}$ indicator, " G " or microdot " $\mathrm{=}$ ", may or may not be present. Some products may not follow the Generic Marking.
*For additional information on our $\mathrm{Pb}-$ Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## STYLES ON PAGE 2

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| DESCRIPTION: | SOIC-8 NB | PAGE 1 OF 2 |

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SOIC-8 NB
CASE 751-07
ISSUE AK
DATE 16 FEB 2011

STYLE

| PIN 1. | EMITTER |
| ---: | :--- |
| 2. | COLLECTOR |
| 3. | COLLECTOR |
| 4. | EMITTER |
| 5. | EMITTER |
| 6. | BASE |
| 7. | BASE |
| 8. | EMITTER |
| STYLE 5: |  |
| PIN 1. | DRAIN |
| 2. | DRAIN |
| 3. | DRAIN |
| 4. | DRAIN |
| 5. | GATE |
| 6. | GATE |
| 7. | SOURCE |
| 8. | SOURCE |

STYLE 9:
PIN 1. EMITTER, COMMON
COLLECTOR, DIE \#1 COLLECTOR, DIE \#2 EMITTER, COMMON EMITTER, COMMON BASE, DIE \#2
BASE, DIE \#
8. EMITTER, COMMON

STYLE 13:
PIN 1. N.C.
2. SOURCE
3. SOURCE

GATE
DRAIN
DRAIN
DRAIN
8. DRAIN

STYLE 17:
PIN 1. VCC
V2OUT
V10UT
V10UT
TXE
RXE
VEE
7. GND
8. ACC

STYLE 21:
PIN 1. CATHODE 1
2. CATHODE 2
3. CATHODE 3

CATHODE 4
CATHODE 5
6. COMMON ANODE
7. COMMON ANODE
8. CATHODE 6

STYLE 25:
PIN 1. VIN
2. $N / C$

REXT
GND
IOUT
IOUT
IOUT
8. IOUT

## STYLE 29

PIN 1. BASE, DIE \#
EMITTER, \#1
BASE, \#2
. EMITTER, \#2
5. COLLECTOR, \#2
6. COLLECTOR, \#2
7. COLLECTOR, \#1
7. COLLECTOR, \#1

STYLE 2:
PIN 1. COLLECTOR,
2. COLLECTOR, \#1
3. COLLECTOR, \#2

COLLECTOR, \#2
BASE, \#2
. EMITTER, \#2
7. BASE, \#1
8. EMITTER, \#1

STYLE 6:
PIN 1. SOURCE
DRAIN
3. DRAIN
4. SOURCE

SOURCE
6. GATE
7. GATE
8. SOURCE

STYLE 10:
PIN 1. GROUND
2. BIAS 1
3. OUTPUT

GROUND
GROUND
BIAS 2
7. INPUT
8. GROUND

STYLE 14:
PIN 1. N-SOURCE
2. N-GATE

P-SOURCE
P-GATE
5. P-DRAIN
6. P-DRAIN
7. N -DRAIN
8. N -DRAIN

STYLE 18
PIN 1. ANODE
2. ANODE
3. SOURCE
4. GATE
5. DRAIN
6. DRAIN
7. CATHODE
8. CATHODE

STYLE 22 :
PIN 1. I/O LINE
2. COMMON CATHODE/VCC
3. COMMON CATHODE/VCC
4. I/O LINE 3
5. COMMON ANODE/GND
6. I/O LINE 4
7. I/O LINE 5
8. COMMON ANODE/GND

STYLE 26:
PIN 1. GND
2. $\mathrm{dv} / \mathrm{dt}$
3. ENABLE
3. ENABLE
4. ILIMIT

SOURCE
SOURCE
SOURCE
8. VCC

STYLE 30:
PIN 1. DRAIN 1
2. DRAIN 1
. GATE 2
4. SOURCE 2
5. SOURCE 1/DRAIN 2
. SOURCE 1/DRAIN 2
SOURCE 1/DRAIN 2
8. GATE 1

STYLE 3
STYLE
2. DRAIN, DIE
2. DRAIN, \#1
2. DRAIN, \#
3. DRAIN, \#2
4. DRAIN, \#2
5. GATE, \#2
7. GATE, \#1
8. SOURCE, \#1

## STYLE 7

PIN 1. INPUT
2. EXTERNAL BYPASS
3. THIRD STAGE SOURCE
4. GROUND
5. DRAIN
6. GATE 3
7. SECOND STAGE Vd
8. FIRST STAGE Vd

## STYLE 11:

PIN 1. SOURCE
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 2
7. DRAIN 1
8. DRAIN 1

## STYLE 15:

PIN 1. ANODE 1
2. ANODE 1
3. ANODE 1
4. ANODE 1
5. CATHODE, COMMON
6. CATHODE, COMMON
7. CATHODE, COMMON
8. CATHODE, COMMON

## STYLE 19:

PIN 1. SOURCE
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. MIRROR 2
7. DRAIN 1
8. MIRROR 1

## STYLE 23:

PIN 1. LINE 1 IN
2. COMMON ANODE/GND
3. COMMON ANODE/GND
4. LINE 2 IN
5. LINE 2 OUT
6. COMMON ANODE/GND
7. COMMON ANODE/GND
8. LINE 1 OUT

STYLE 27:
PIN 1. ILIMIT
2. OVLO
3. UVLO
4. INPUT+
5. INPUT+
5. SOURCE
6. SOURCE
7. SOURCE
8. DRAIN

STYLE 4:
PIN 1. ANODE
2. ANODE
3. ANODE
4. ANODE
5. ANODE
6. ANODE
8. COMMON CATHODE

## STYLE 8:

PIN 1. COLLECTOR, DIE \#1
2. BASE, \#1
3. BASE, \#2
4. COLLECTOR, \#2
5. COLLECTOR, \#2
6. EMITTER, \#2
7. EMITTER, \#1
8. COLLECTOR, \#1

## STYLE 12

PIN 1. SOURCE
2. SOURCE
3. SOURCE
4. GATE
5. DRAIN
6. DRAIN
7. DRAIN
8. DRAIN

## STYLE 16:

PIN 1. EMITTER, DIE \#1
2. BASE, DIE \#1
3. EMITTER, DIE \#2
3. EMITTER, DIE
4. BASE, DIE \#2
4. BASE, DIE \#2
6. COLLECTOR, DIE \#2
7. COLLECTOR, DIE \#1
8. COLLECTOR, DIE \#1

## STYLE 20:

PIN 1. SOURCE (N)
2. GATE (N)
3. SOURCE (P)
4. GATE (P)
5. DRAIN
6. DRAIN
7. DRAIN
8. DRAIN

STYLE 24
PIN 1. BASE
2. EMITTER
3. COLLECTOR/ANODE
4. COLLECTOR/ANODE
5. CATHODE
6. CATHODE
7. COLLECTOR/ANODE
8. COLLECTOR/ANODE

## STYLE 28:

PIN 1. SW_TO_GND
2. DASIC $\bar{O} F F$
3. DASIC_SW_DET
4. GND
5. V_MON
6. VBUULK
7. VBULK
8. VIN

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TSSOP 8

## CASE 948R-02

ISSUE A
DATE 04/07/2000

## SCALE 2:1


notes:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PROTRUSI
PER SIDE
5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY
6. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-

|  | MILLIMETERS |  | INCHES |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |  |  |
| A | 2.90 | 3.10 | 0.114 | 0.122 |  |  |
| B | 2.90 | 3.10 | 0.114 | 0.122 |  |  |
| C | 0.80 | 1.10 | 0.031 | 0.043 |  |  |
| D | 0.05 | 0.15 | 0.002 | 0.006 |  |  |
| F | 0.40 | 0.70 | 0.016 | 0.028 |  |  |
| G | 0.65 BSC |  | 0.026 BSC |  |  |  |
| K | 0.25 |  | 0.40 | 0.010 |  | 0.016 |
| L | 4.90 BSC |  | 0.193 BSC |  |  |  |
| M | $0^{\circ}$ |  | $6^{\circ}$ | $0^{\circ}$ |  | $6^{\circ}$ |


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